





Texas INSTRUMENTS

SN54HCT541, SN74HCT541 SCLS306E - JANUARY 1996 - REVISED MAY 2022

## SNx4HCT541 Octal Buffers and Line Drivers With 3-State Outputs

### 1 Features

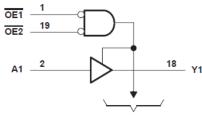
- Operating voltage range of 4.5 V to 5.5 V
- High-current 3-state outputs interface • directly with system bus or can drive up to 15 LSTTL loads
- Low power consumption, 80-µA max I<sub>CC</sub> •
- Typical t<sub>pd</sub> = 12 ns •
- ±6-mA output drive at 5 V
- Low input current of 1 µA max ٠
- Inputs are TTL-voltage compatible ٠
- Data flow-through pinout (all inputs on opposite ٠ side from outputs)

### 2 Description

These octal buffers and line drivers are designed to have the performance of the popular 'HC240 series devices and to offer a pinout with inputs and outputs on opposite sides of the package. This arrangement greatly facilitates printed circuit board layout.

Device Information							
PART NUMBER PACKAGE <sup>(1)</sup> BODY SIZE (NOM)							
SN74HCT541DW	SOIC (20)	12.80 mm × 7.50 mm					
SN74HCT541DB	SSOP (20)	7.20 mm × 5.30 mm					
SN74HCT541N	PDIP (20)	25.40 mm × 6.35 mm					
SN74HCT541NS	SO (20)	15.00 mm × 5.30 mm					
SN74HCT541PW	TSSOP (20)	6.50 mm × 4.40 mm					
SN54HCT541J	CDIP (20)	26.92 mm × 6.92 mm					
SNJ54HCT541FK	LCCC (20)	8.89 mm × 8.45 mm					

For all available packages, see the orderable addendum at (1) the end of the data sheet.



**To Seven Other Channels** 







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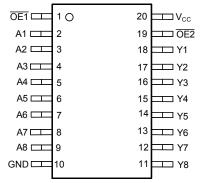
### **3 Revision History**

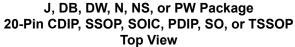
NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

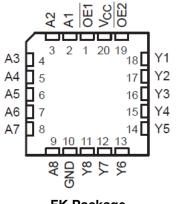
С	Changes from Revision D (February 2022) to Revision E (May 2022)	Page
•	Junction-to-ambient thermal resistance values increased. DW was 58 is now 109.1, DB was 70 is now N was 69 is now 84.6, NS was 60 is now 113.4, PW was 83 is now 131.8	
С	Changes from Revision C (August 2003) to Revision D (February 2022)	Page



### **4** Pin Configuration and Functions







FK Package 20-Pin LCCC Top View



### 5 Specifications

#### 5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage range		-0.5	7	V
I <sub>IK</sub>	Input clamp current <sup>(2)</sup>	$V_{I} < 0 \text{ or } V_{I} > V_{CC}$		±20	mA
I <sub>OK</sub>	Output clamp current <sup>(2)</sup>	$V_{O}$ < 0 or $V_{O}$ > $V_{CC}$		±20	mA
I <sub>O</sub>	Continuous output current	$V_{O} = 0$ to $V_{CC}$		±35	mA
	Continuous current through $V_{CC}$ or GND			±70	mA
TJ	Junction temperature			150	°C
T <sub>stg</sub>	Storage temperature range		-65	150	°C

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

#### 5.2 Recommended Operating Conditions<sup>(1)</sup>

			SN	54HCT54	1	SN	74HCT54	41	UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	UNIT
V <sub>CC</sub>	Supply voltage		4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	V <sub>CC</sub> = 4.5 V to 5.5 V	2			2			V
VIL	Low-level input voltage	V <sub>CC</sub> = 4.5 V to 5.5 V			0.8			0.8	V
VI	Input voltage	·	0		V <sub>CC</sub>	0		V <sub>CC</sub>	V
Vo	Output voltage		0		V <sub>CC</sub>	0		V <sub>CC</sub>	V
Δt/Δv	Input transition rise and fall	time			500			500	ns
T <sub>A</sub>	Operating free-air temperat	ure	-55		125	-40		85	°C

 All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

#### **5.3 Thermal Information**

		DW (SOIC)	DB (SSOP)	N (PDIP)	NS (SO)	PW (TSSOP)	
THERMAL I	METRIC	20 PINS	20 PINS	20 PINS	20 PINS	20 PINS	UNIT
R <sub>θJA</sub>	Junction-to-ambient thermal resistance	109.1	122.7	84.6	113.4	131.8	°C/W
R <sub>0JC (top)</sub>	Junction-to-case (top) thermal resistance	76	81.6	72.5	78.6	72.2	°C/W
$R_{\theta J B}$	Junction-to-board thermal resistance	77.6	77.5	65.3	78.4	82.8	°C/W
$\Psi_{JT}$	Junction-to-top characterization parameter	51.5	46.1	55.3	47.1	21.5	°C/W
$\Psi_{JB}$	Junction-to-board characterization parameter	77.1	77.1	65.2	78.1	82.4	°C/W
R <sub>0JC(bot)</sub>	Junction-to-case (bottom) thermal resistance	N/A	N/A	N/A	N/A	N/A	°C/W



### **5.4 Electrical Characteristics**

PARAMETER	TEST CO		V	T,	<sub>A</sub> = 25°C		SN54HC	CT541	SN74HC	CT541	UNIT
PARAMETER	TEST CONDITIONS		V <sub>cc</sub>	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
V <sub>OH</sub>	$V_{i} = V_{i}$ or $V_{i}$	I <sub>OH</sub> = -20 μA	4.5 V	4.4	4.499		4.4		4.4		V
VOH		I <sub>OH</sub> = -20 μA I <sub>OH</sub> = -6 mA	4.5 V -	3.98	4.3		3.7		3.84		v
V <sub>OL</sub>	V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = 20 μA	4.5 V		0.001	0.1		0.1		0.1	V
VOL		I <sub>OL</sub> = 6 mA	4.5 V		0.17	0.26		0.4		0.33	v
I <sub>I</sub>	$V_{I} = V_{CC} \text{ or } 0$		5.5 V		±0.1	±100		±1000		±1000	nA
I <sub>OZ</sub>	$V_{O} = V_{CC} \text{ or } 0,$	$V_{I} = V_{IH} \text{ or } V_{IL}$	5.5 V		±0.01	±0.5		±10		±5	μA
I <sub>CC</sub>	$V_{I} = V_{CC} \text{ or } 0,$	I <sub>O</sub> = 0	5.5 V			8		160		80	μA
$\Delta I_{CC}$ <sup>(1)</sup>	One input at 0. Other inputs at	,	5.5 V		1.4	2.4		3		2.9	mA
Ci			4.5 V to 5.5 V		3	10		10		10	pF

over recommended operating free-air temperature range (unless otherwise noted)

(1) This is the increase in supply current for each input that is at one of the specified TTL voltage levels, rather than 0 V or V<sub>CC</sub>.

#### 5.5 Switching Characteristics

over recommended operating free-air temperature range, C<sub>L</sub> = 50 pF (unless otherwise noted) (see Figure 6-1)

PARAMETER	FROM	то	Vee	T <sub>A</sub> = 25°C		SN54HCT541	SN74HCT541	UNIT	
PARAMETER	(INPUT)	(OUTPUT)	V <sub>cc</sub>	MIN	TYP	MAX	MIN MAX	MIN MAX	UNIT
<b>f</b> .	А	Y	4.5 V		13	23	34	29	ns
t <sub>pd</sub>	~	Ŷ	5.5 V		12	21	31	26	115
t	ŌĒ	Y	4.5 V		21	30	45	38	ns
t <sub>en</sub>	0L		5.5 V		19	27	41	34	115
<b>t</b>	ŌĒ	Y	4.5 V		19	30	45	38	ns
t <sub>dis</sub>	OL		5.5 V		18	27	41	34	115
tt		Y	4.5 V		8	12	18	15	ns
			5.5 V		7	11	16	14	115

#### **5.6 Switching Characteristics**

over recommended operating free-air temperature range, C<sub>L</sub> = 150 pF (unless otherwise noted) (see Figure 6-1)

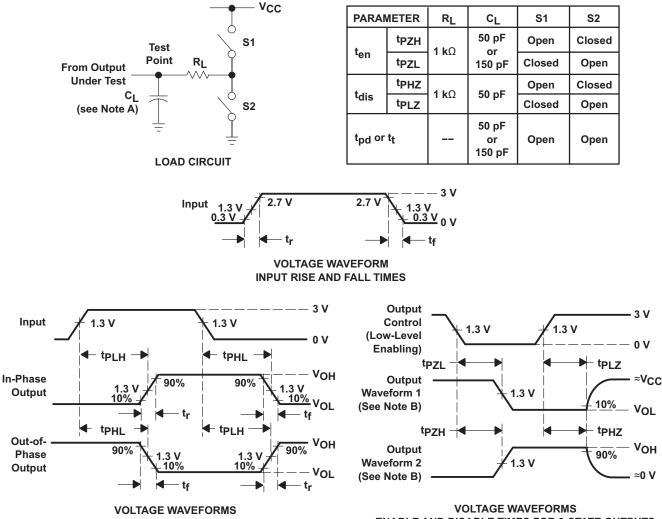
PARAMETER	FROM	то	V <sub>cc</sub>	T <sub>A</sub>	= 25°C		SN54HCT54	1	SN74HC	T541	UNIT	
	(INPUT)	(OUTPUT)	(OUTPUT)	VCC	MIN	TYP	MAX	MIN M	AX	MIN	MAX	UNIT
+ .	А	V	4.5 V		20	33		49		42	ns	
Lpd	A	T	5.5 V		19	30		45		38	115	
+	ŌĒ	V	4.5 V		26	40		60		50	20	
Len	UL	I	5.5 V		25	36		54		45	ns	
+		V	4.5 V		17	42		63		53	ns	
Lt.		I	5.5 V		14	38		57		48	115	

### **5.7 Operating Characteristics**

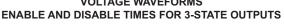
T<sub>A</sub> = 25°C

PARAMETER		TEST CONDITIONS	ТҮР	UNIT
C <sub>pd</sub>	Power dissipation capacitance per buffer/driver	No load	35	pF

#### **6** Parameter Measurement Information



## PROPAGATION DELAY AND OUTPUT RISE AND FALL TIMES



- NOTES: A. C<sub>L</sub> includes probe and test-fixture capacitance.
  - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
  - C. Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz, Z<sub>Q</sub> = 50 Ω, t<sub>r</sub> = 6 ns.
  - D. The outputs are measured one at a time with one input transition per measurement.
  - E.  $t_{PI 7}$  and  $t_{PH7}$  are the same as  $t_{dis}$ .
  - F.  $t_{P7I}$  and  $t_{P7H}$  are the same as  $t_{en}$ .
  - G. tpLH and tpHL are the same as  $t_{pd}$ .

#### Figure 6-1. Load Circuit and Voltage Waveforms



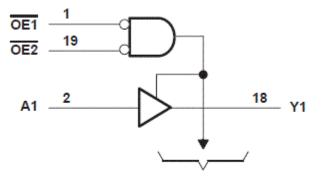
### 7 Detailed Description

#### 7.1 Overview

These octal buffers and line drivers are designed to have the performance of the popular 'HC240 series devices and to offer a pinout with inputs and outputs on opposite sides of the package. This arrangement greatly facilitates printed circuit board layout.

The 3-state control gate is a 2-input NOR. If either output-enable ( $\overline{OE1}$  or  $\overline{OE2}$ ) input is high, all eight outputs are in the high-impedance state. The 'HCT541 devices provide true data at the outputs.

#### 7.2 Functional Block Diagram



To Seven Other Channels

#### 7.3 Device Functional Modes

# Table 7-1. Function Table (Each Buffer/Driver)

	OUTPUT		
OE1	OE2	A	Y
L	L	L	L
L	L	Н	Н
Н	Х	Х	Z
X	Н	Х	Z



#### 8 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the *Recommended Operating Conditions*. Each  $V_{CC}$  terminal should have a good bypass capacitor to prevent power disturbance. A 0.1- $\mu$ F capacitor is recommended for this device. It is acceptable to parallel multiple bypass caps to reject different frequencies of noise. The 0.1- $\mu$ F and 1- $\mu$ F capacitors are commonly used in parallel. The bypass capacitor should be installed as close to the power terminal as possible for best results.

#### 9 Layout

#### 9.1 Layout Guidelines

When using multiple-input and multiple-channel logic devices inputs must not ever be left floating. In many cases, functions or parts of functions of digital logic devices are unused; for example, when only two inputs of a triple-input AND gate are used or only 3 of the 4 buffer gates are used. Such unused input pins must not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. All unused inputs of digital logic devices must be connected to a logic high or logic low voltage, as defined by the input voltage specifications, to prevent them from floating. The logic level that must be applied to any particular unused input depends on the function of the device. Generally, the inputs are tied to GND or  $V_{CC}$ , whichever makes more sense for the logic function or is more convenient.



### **10 Device and Documentation Support**

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

#### **10.1 Receiving Notification of Documentation Updates**

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

#### **10.2 Support Resources**

TI E2E<sup>™</sup> support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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#### 10.3 Trademarks

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#### **10.4 Electrostatic Discharge Caution**



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### 10.5 Glossary

TI Glossary This glossary lists and explains terms, acronyms, and definitions.



### 11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



### PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
JM38510/65761BRA	ACTIVE	CDIP	J	20	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	JM38510/ 65761BRA	Samples
M38510/65761BRA	ACTIVE	CDIP	J	20	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	JM38510/ 65761BRA	Samples
SN54HCT541J	ACTIVE	CDIP	J	20	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	SN54HCT541J	Samples
SN74HCT541DBR	ACTIVE	SSOP	DB	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HT541	Samples
SN74HCT541DW	ACTIVE	SOIC	DW	20	25	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HCT541	Samples
SN74HCT541DWE4	ACTIVE	SOIC	DW	20	25	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HCT541	Samples
SN74HCT541DWG4	ACTIVE	SOIC	DW	20	25	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HCT541	Samples
SN74HCT541DWR	ACTIVE	SOIC	DW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HCT541	Samples
SN74HCT541DWRE4	ACTIVE	SOIC	DW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HCT541	Samples
SN74HCT541DWRG4	ACTIVE	SOIC	DW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HCT541	Samples
SN74HCT541N	ACTIVE	PDIP	Ν	20	20	RoHS & Green	NIPDAU	N / A for Pkg Type	-40 to 85	SN74HCT541N	Samples
SN74HCT541NSR	ACTIVE	SO	NS	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HCT541	Samples
SN74HCT541NSRE4	ACTIVE	SO	NS	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HCT541	Samples
SN74HCT541NSRG4	ACTIVE	SO	NS	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HCT541	Samples
SN74HCT541PW	ACTIVE	TSSOP	PW	20	70	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HT541	Samples
SN74HCT541PWG4	ACTIVE	TSSOP	PW	20	70	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HT541	Samples
SN74HCT541PWR	ACTIVE	TSSOP	PW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HT541	Samples
SN74HCT541PWRG4	ACTIVE	TSSOP	PW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HT541	Samples
SN74HCT541PWT	ACTIVE	TSSOP	PW	20	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HT541	Samples

Orderable Device	Status (1)	Package Typ	e Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
SNJ54HCT541FK	ACTIVE	LCCC	FK	20	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	SNJ54HCT 541FK	Samples
SNJ54HCT541J	ACTIVE	CDIP	J	20	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	SNJ54HCT541J	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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#### OTHER QUALIFIED VERSIONS OF SN54HCT541, SN74HCT541 :

• Catalog : SN74HCT541

• Military : SN54HCT541

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications



Texas

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#### TAPE AND REEL INFORMATION





#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74HCT541DBR	SSOP	DB	20	2000	330.0	16.4	8.2	7.5	2.5	12.0	16.0	Q1
SN74HCT541DWR	SOIC	DW	20	2000	330.0	24.4	10.9	13.3	2.7	12.0	24.0	Q1
SN74HCT541NSR	SO	NS	20	2000	330.0	24.4	8.4	13.0	2.5	12.0	24.0	Q1
SN74HCT541PWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.0	1.4	8.0	16.0	Q1
SN74HCT541PWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.0	1.4	8.0	16.0	Q1
SN74HCT541PWT	TSSOP	PW	20	250	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1



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## PACKAGE MATERIALS INFORMATION

22-Nov-2022



All ultrensions are normal							r.
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74HCT541DBR	SSOP	DB	20	2000	356.0	356.0	35.0
SN74HCT541DWR	SOIC	DW	20	2000	367.0	367.0	45.0
SN74HCT541NSR	SO	NS	20	2000	367.0	367.0	45.0
SN74HCT541PWR	TSSOP	PW	20	2000	356.0	356.0	35.0
SN74HCT541PWR	TSSOP	PW	20	2000	356.0	356.0	35.0
SN74HCT541PWT	TSSOP	PW	20	250	356.0	356.0	35.0

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### TUBE



### - B - Alignment groove width

#### \*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	Τ (μm)	B (mm)
SN74HCT541DW	DW	SOIC	20	25	507	12.83	5080	6.6
SN74HCT541DWE4	DW	SOIC	20	25	507	12.83	5080	6.6
SN74HCT541DWG4	DW	SOIC	20	25	507	12.83	5080	6.6
SN74HCT541N	N	PDIP	20	20	506	13.97	11230	4.32
SN74HCT541PW	PW	TSSOP	20	70	530	10.2	3600	3.5
SN74HCT541PWG4	PW	TSSOP	20	70	530	10.2	3600	3.5
SNJ54HCT541FK	FK	LCCC	20	1	506.98	12.06	2030	NA

## **DB0020A**



## **PACKAGE OUTLINE**

SSOP - 2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-150.



## DB0020A

## **EXAMPLE BOARD LAYOUT**

## SSOP - 2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



## DB0020A

## **EXAMPLE STENCIL DESIGN**

## SSOP - 2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



### MECHANICAL DATA

#### PLASTIC SMALL-OUTLINE PACKAGE

#### 0,51 0,35 ⊕0,25⊛ 1,27 8 14 0,15 NOM 5,60 8,20 5,00 7,40 $\bigcirc$ Gage Plane ₽ 0,25 7 1 1,05 0,55 0°-10° Δ 0,15 0,05 Seating Plane — 2,00 MAX 0,10PINS \*\* 14 16 20 24 DIM 10,50 10,50 12,90 15,30 A MAX A MIN 9,90 9,90 12,30 14,70 4040062/C 03/03

NOTES: A. All linear dimensions are in millimeters.

NS (R-PDSO-G\*\*)

**14-PINS SHOWN** 

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



J (R-GDIP-T\*\*) 14 LEADS SHOWN

CERAMIC DUAL IN-LINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

## N (R-PDIP-T\*\*)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- $\triangle$  The 20 pin end lead shoulder width is a vendor option, either half or full width.



## **DW0020A**



## **PACKAGE OUTLINE**

### SOIC - 2.65 mm max height

SOIC



NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
- 5. Reference JEDEC registration MS-013.



## DW0020A

## **EXAMPLE BOARD LAYOUT**

### SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



## DW0020A

## **EXAMPLE STENCIL DESIGN**

### SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



## **PW0020A**



## **PACKAGE OUTLINE**

## TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



## PW0020A

## **EXAMPLE BOARD LAYOUT**

### TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



## PW0020A

## **EXAMPLE STENCIL DESIGN**

## TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



## LAND PATTERN DATA



NOTES: Α. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
  C. Publication IPC-7351 is recommended for alternate design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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